



Product Change Notification / LIAL-13ERYV184

Date:

29-Jul-2021

Product Category:

Memory

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4198.001 Final Notice: Qualification of ASSH as a new assembly site for selected 24xx01, 24xx02, 24xx04, 24xx08 and 24xx16 device families available in 8L TSSOP package.

Affected CPNs:

[LIAL-13ERYV184_Affected_CPN_07292021.pdf](#)

[LIAL-13ERYV184_Affected_CPN_07292021.csv](#)

Notification Text:

PCN Status:Final notification.

PCN Type: Manufacturing Change

Microchip Parts Affected:Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of ASSH as a new assembly site for selected 24xx01, 24xx02, 24xx04, 24xx08 and 24xx16 device families available in 8L TSSOP package.

Pre Change:

Assembled at MMT using gold (Au) bond wire, 2200D die attach material, G600V molding compound material, with Matte tin lead plating finish and using lead frame without lead lock

Post Change:

Assembled at ASSH using palladium coated copper (PdCu) bond wire, EN-4900GC die attach material, G700LY molding

compound material, with Ru-PPF lead plating finish and using lead frame with lead lock

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	Microchip Technology Thailand (MMT)	ASE Advanced Semiconductor (Shanghai) Co., Ltd ASSH
Wire material	Au	PdCu
Die attach material	2200D	EN-4900GC
Molding compound material	G600V	G700LY
Lead frame material	C7025	C7025
Lead Plating Finish	Matte tin	Ru-PPF
Lead frame lead-lock	No	Yes
	See Pre and Post Change attachment for lead frame comparison.	

Impacts to Data Sheet: None

Change Impact:None

Reason for Change:To improve on-time delivery performance by qualifying ASSH as a new assembly site.

Change Implementation Status:In Progress

Estimated First Ship Date:February 9, 2021 (date code: 2107)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

Workweek	January 2021					February 2021				
	01	02	03	04	05	06	07	08	09	
Qual Report Availability				X						
Final PCN Issue Date				X						
Estimated Implementation Date							X			

Method to Identify Change: Traceability code

Qualification Report: Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:January 18, 2021: Issued final notification. Attached the Qualification Report. Provided estimated first ship

date to be on February 9, 2021.**July 29, 2021:** Re-issued final notification to update the qualification report. The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

[PCN_LIAL-13ERYV184_Qual Report_Rev1.pdf](#)
[PCN_LIAL-13ERYV184_Pre and Post Change Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

Terms and Conditions:

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If you wish to change your PCN profile, including opt out, please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

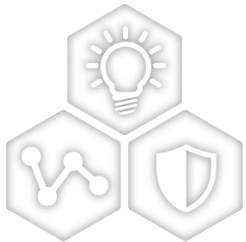
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24LC08B-E/ST
24LC08BH-E/ST
24LC08BH-I/ST
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24LC08B-I/ST
24LC08BT/ST
24LC08BT-E/ST
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24LC16B-E/ST
24LC16BH-E/ST
24LC16BH-I/ST
24LC16BHT-E/ST
24LC16BHT-I/ST
24LC16B-I/ST
24LC16BT/ST
24LC16BT-E/ST
24LC16BT-I/ST
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24AA01T-I/ST
24AA02/ST
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24AA08HT-I/ST
24AA08-I/ST
24AA08T-I/ST
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24AA16H-I/ST
24AA16HT-I/ST
24AA16-I/ST
24AA16T-E/ST

CCB 4198.001
Pre and Post Change Summary
PCN #: LIAL-13ERYV184



A Leading Provider of Smart, Connected and Secure Embedded Control Solutions

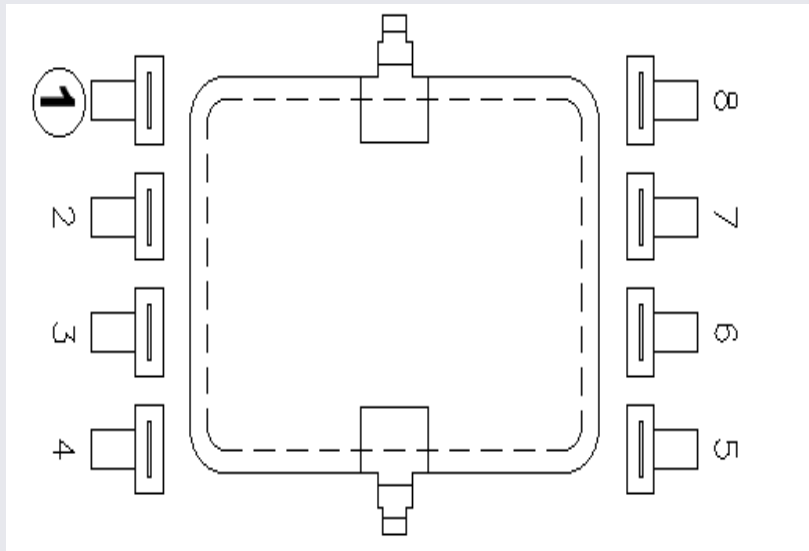


SMART | CONNECTED | SECURE

Lead frame comparison

Pre change

MMT

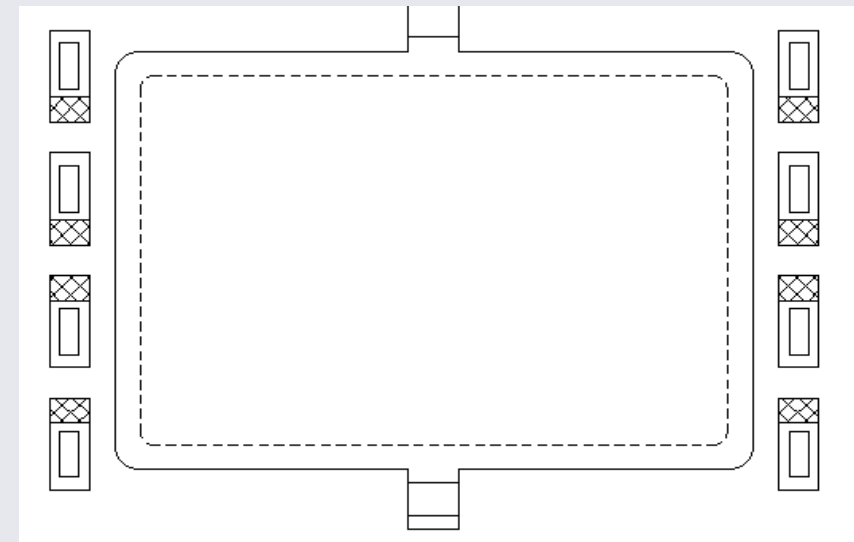


Lead frame lead-lock

No

Post Change

ASSH



Lead frame lead-lock

Yes



QUALIFICATION REPORT SUMMARY
RELIABILITY LABORATORY

PCN#: LIAL-13ERYV184

Date
October 30, 2020

**Qualification of ASSH as a new assembly site for selected
24xx01, 24xx02, 24xx04, 24xx08 and 24xx16 device families
available in 8L TSSOP package.**



MICROCHIP PACKAGE QUALIFICATION REPORT

Purpose	Qualification of ASSH as a new assembly site for selected 24xx01, 24xx02, 24xx04, 24xx08 and 24xx16 device families available in 8L TSSOP package.
CN	ES345370
CCB	4198.001
QUAL ID	R2000526 Rev B
MP CODE	3583079CXC03
Part No.	AT24C256C-XHL-B
Bonding No.	W35830ayu
<u>Package</u>	
Type	8L TSSOP
Package size	4.4 mm
<u>Lead Frame</u>	
Paddle size	2.21 x 3.2 mils
Material	C7025
Surface	Ru-PPF
Process	Stamped
Lead Lock	Yes
Part Number	LI-WMA400008-05-00
Treatment	Roughened
<u>Material</u>	
Epoxy	EN-4900GC
Wire	PdCu
Mold Compound	G700LY
Plating Composition	Ru-PPF



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
ASSH184000082.000	MCSO518384144.000	1752USC
ASSH204400040.000	MCSO520177622.000	20057CC
ASSH204700076.000	MCSO520167575.000	2008CDJ

Result

Pass Fail _____

8L TSSOP assembled by ASSH pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020E)	IPC/JEDEC J-STD-020E	135	0/135	Pass	
<u>Precondition</u> <u>Prior Perform</u> <u>Reliability Tests</u> (At MSL Level 1)	Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT Bake 150°C, 24 hrs System: CHINEE 85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT	JESD22-A113	693(0)	693 693 693 0/693	 Pass	Good Devices

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H Electrical Test: +85°C and 125°C System: NEXTEST_PT	JESD22-A104	231(0)	231 0/231	Pass	Parts had been pre-conditioned at 260°C
	Bond Strength: Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)			45 (0)	0/45	
	Stress Condition: -65°C to +150°C, 1000 Cycles System: TABAI ESPEC TSA-70H Electrical Test: +85°C and 125°C System: NEXTEST_PT		231(0)	231 0/231	Pass	
	Bond Strength: Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)			45 (0)	0/45	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C
	Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT		231(0)	0/231	Pass	77 units / lot
	Bond Strength: Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)		45 (0)	0/45	Pass	
	Stress Condition: +130°C/85%RH, 192 hrs. Bias Volt: 5.5 Volts System: HAST 6000X			231		
	Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT		231(0)	0/231	Pass	
	Bond Strength: Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)		45 (0)	0/45	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
UNBIASED-HAST	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C
	Electrical Test: +25°C System: NEXTEST_PT		231(0)	0/231	Pass	77 units / lot
High Temperature Storage Life	Stress Condition: Bake 175°C, 500 hrs System: TPS DC-166-F-ST350	JESD22- A103		135		45 units / lot
	Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT		135(0)	0/135	Pass	
	Stress Condition: Bake 175°C, 1000 hrs System: TPS DC-166-F-ST350			135		
Electrical Test: +25°C, 85°C and 125°C System: NEXTEST_PT		135(0)	0/135	Pass		
Solderability Temp 215°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63, Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD- 002	22 (0)	22 22 0/22	Pass	
Solderability Temp 245°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD- 002	22 (0)	22 22 0/22	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Bond Strength Data Assembly	Wire Pull (>8.00 grams)	Mil.Std. 883-2011	30 (0) Wires	0/30	Pass	
	Bond Shear (> 18.00 grams)	CDF-AEC- Q100-001	30 (0) Wires	0/30	Pass	